

**Search Notes**

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Emily Y. Chan

Applicant(s)/Patent under  
Reexamination

KWARK, YOUNG HOON

Art Unit

2829

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

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**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
324/750-765;702;356;250/492.2 (text searched only-see history printout)	8/11/2005	EC